## Notice of References Cited

Application/Control No. 10/535,070	Reexaminati	Applicant(s)/Patent Under Reexamination VAN DEN MEERAKKER ET AL.		
Examiner	Art Unit			
Mahmoud Dahimene	1765	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,987,208	11-1999	Gruning et al.	385/146
*	В	US-5,607,876	03-1997	Biegelsen et al.	438/45
*	С	US-2003/0098640	05-2003	Kishi et al.	313/309
*	D	US-2004/0076681	04-2004	Dennis et al.	424/489
	Ε	US-			
	F	US-			
	G	US-			
	н	US-			
	-	US-			
	J	US-			
	Κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р					
	Q					
	R					
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
4	υ	Van Den Meerakker et al. (Journal of The Electrochemical Society, 147 (7) pages 2757-2761 (2000))
	>	
	8	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.